

Absolute Maximum Ratings

| Symbol | Parameter | Rating | Unit | |
|---|--|-----------------------|--------|------|
| Common Ratings (T_c=25°C Unless Otherwise Noted) | | | | |
| V _{DSS} | Drain-Source Voltage | 80 | V | |
| V _{GSS} | Gate-Source Voltage | 20 | V | |
| T _J | Junction Temperature Range | -55 to 175 | °C | |
| T _{STG} | Storage Temperature Range | -55 to 175 | °C | |
| I _S | Source Current-Continuous(Body Diode) | T _c =25°C | 85 | A |
| Mounted on Large Heat Sink | | | | |
| I _{DM} | Pulsed Drain Current * | T _c =25°C | **400 | A |
| I _D | Continuous Drain Current | T _c =25°C | 85 | A |
| | | T _c =100°C | 60 | A |
| P _D | Maximum Power Dissipation | T _c =25°C | 83.3 | W |
| | | T _c =100°C | 41.7 | W |
| R _{θJC} | Thermal Resistance, Junction-to-Case | | 1.8 | °C/W |
| R _{θJA} | Thermal Resistance, Junction-to-Ambient ** | | 45 | °C/W |
| E _{AS} | SinglePulsed-Avalanche Energy *** | L=0.3mH | 350*** | mJ |

Note: * Repetitive rating pulse width limited by max.junction temperature.

** Surface mounted on 1in2 FR-4 board.

*** Limited by T_{jmax} , starting T_J=25°C, L = 0.3mH, R_G= 25Ω, V_{GS} =10V.

Electrical Characteristics (T_c =25°C Unless Otherwise Noted)

| Symbol | Parameter | Test Conditions | HYG055N08NS1 | | | Unit |
|-------------------------------|----------------------------------|--|--------------|------|------|------|
| | | | Min | Typ. | Max | |
| Static Characteristics | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} =0V,I _{DS} = 250 A | 80 | - | - | V |
| I _{DSS} | Drain-to-Source Leakage Current | V _{DS} = 80V,V _{GS} =0V | - | - | 1 | A |
| | | | - | - | 50 | A |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _{DS} = 250 A | 2 | 3 | 4 | V |
| I _{GSS} | Gate-Source Leakage Current | V _{GS} = 20V,V _{DS} =0V | - | - | ±100 | nA |
| R _{DS(ON)} | Drain-Source On-State Resistance | V _{GS} = 10V,I _{DS} =20A | - | 4.8 | 6.0 | mΩ |
| Diode Characteristics | | | | | | |
| V _{SD} | Diode Forward Voltage | I _{SD} =20A,V _{GS} =0V | - | 0.92 | 1.2 | V |
| t _{rr} | Reverse Recovery Time | I _{SD} =50A,dI _{SD} /dt=100A/ | - | 57 | - | ns |
| Q _{rr} | Reverse Recovery Charge | | - | 98 | - | nC |

Electrical Characteristics (Cont.) ($T_c = 25^\circ\text{C}$ Unless Otherwise Noted)

| Symbol | Parameter | Test Condition | HYG055N08NS1 | | | Unit |
|------------------------------------|------------------------------|---|--------------|------|-----|----------|
| | | | Min | Typ. | Max | |
| Dynamic Characteristics | | | | | | |
| R_G | Gate Resistance | $V_{DD} = 10V, V_{GS} = 0V, I_D = 1A$ | - | 3 | - | Ω |
| C_{iss} | Input Capacitance | $V_{DD} = 10V, V_{GS} = 0V, I_D = 1A$ $V_{DD} = 10V, V_{GS} = -1.5V, I_D = 1A$ Frequency = 1.0MHz | - | 3660 | - | pF |
| C_{oss} | Output Capacitance | | - | 1540 | - | |
| C_{rss} | Reverse Transfer Capacitance | | - | 15 | - | |
| $t_{d(ON)}$ | Turn-on Delay Time | $V_{DD} = 10V, V_{GS} = 1.0V, I_D = 1A$ $I_{DS(on)} = 50A, V_{GS} = 1.0V$ | - | 16 | - | ns |
| T_r | Turn-on Rise Time | | - | 89 | - | |
| $t_{d(OFF)}$ | Turn-off Delay Time | | - | 44 | - | |
| T_f | Turn-off Fall Time | | - | 93 | - | |
| Gate Charge Characteristics | | | | | | |
| | Q_g | | | | | |

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Typical Operating Characteristics

Figure 1: Power Dissipation

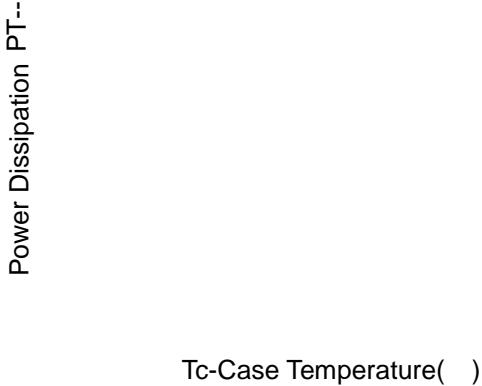


Figure 2: Drain Current

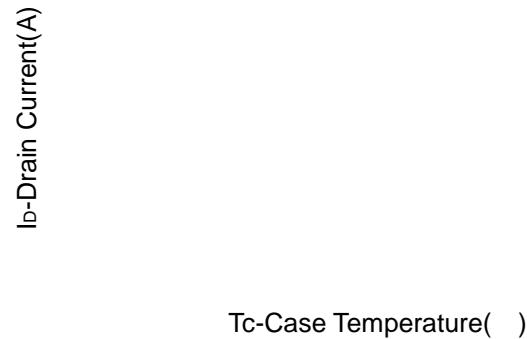


Figure 3: Safe Operation Area

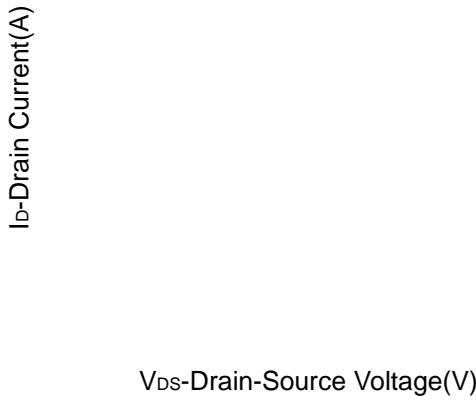


Figure 4: Thermal Transient Impedance

Maximum Effective Transient Thermal Impedance, Junction-to-Case

Figure 5: Output Characteristics



Figure 6: Drain-Source On Resistance



Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

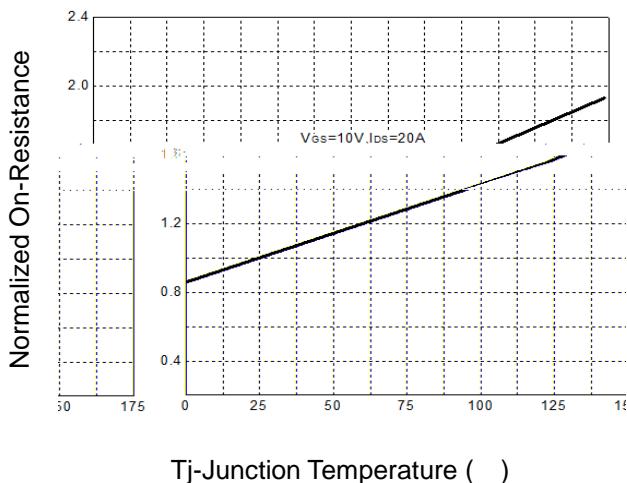


Figure 8: Source-Drain Diode Forward

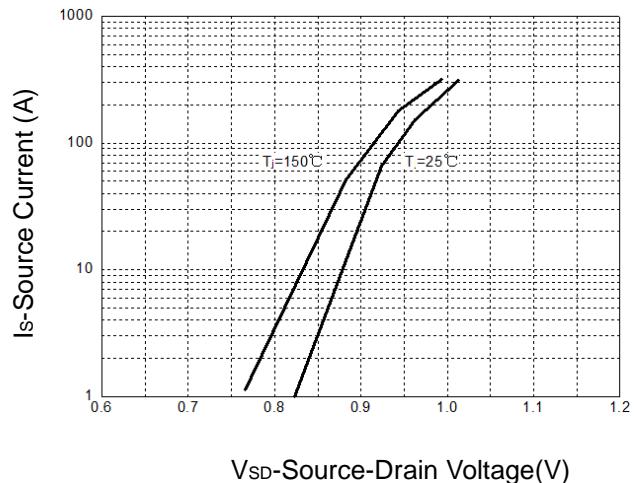


Figure 9: Capacitance Characteristics

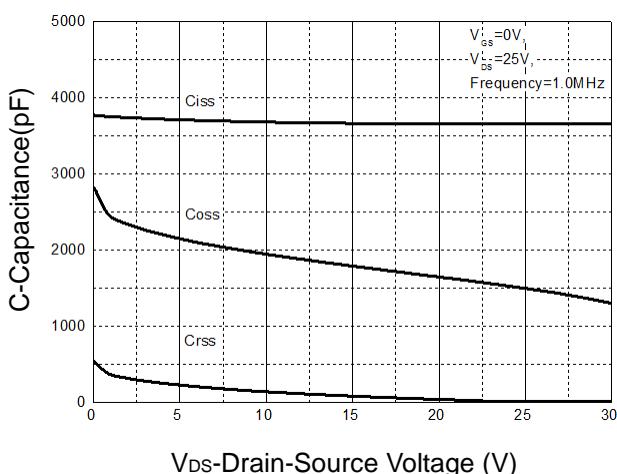
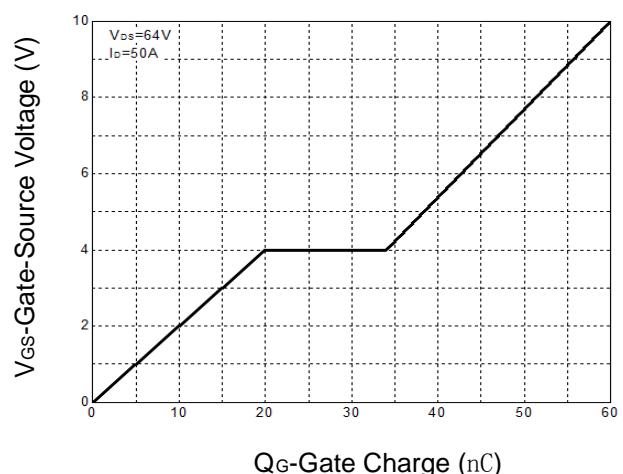
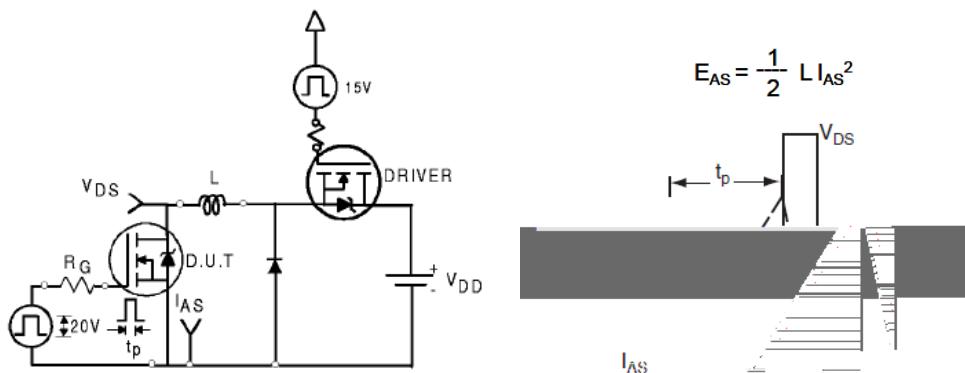


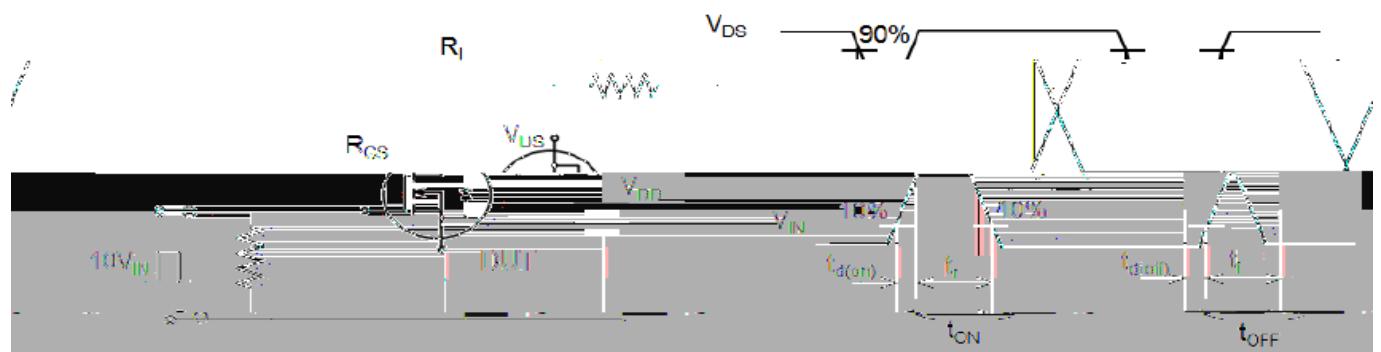
Figure 10: Gate Charge Characteristics



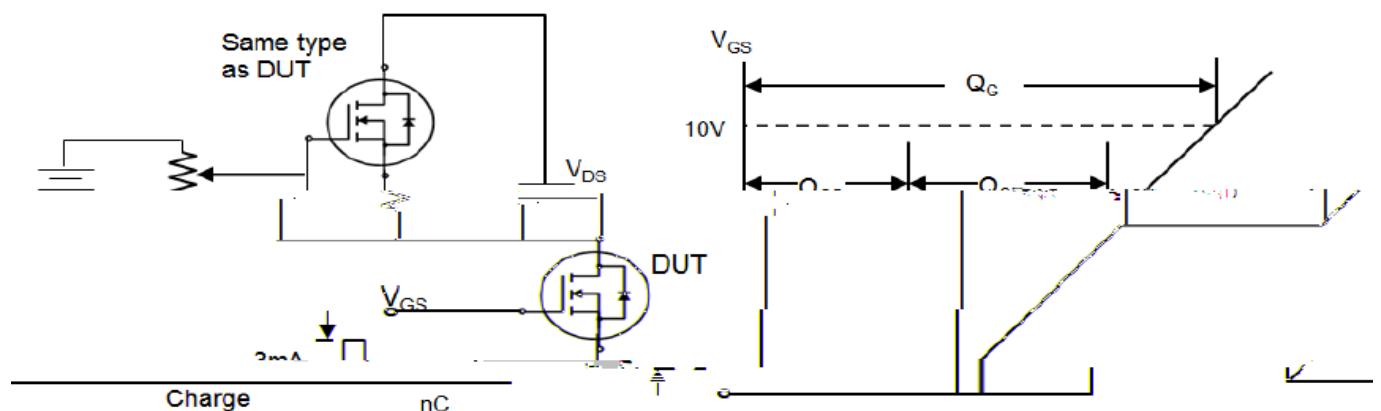
Avalanche Test Circuit



Switching Time Test Circuit



Gate Charge Test Circuit



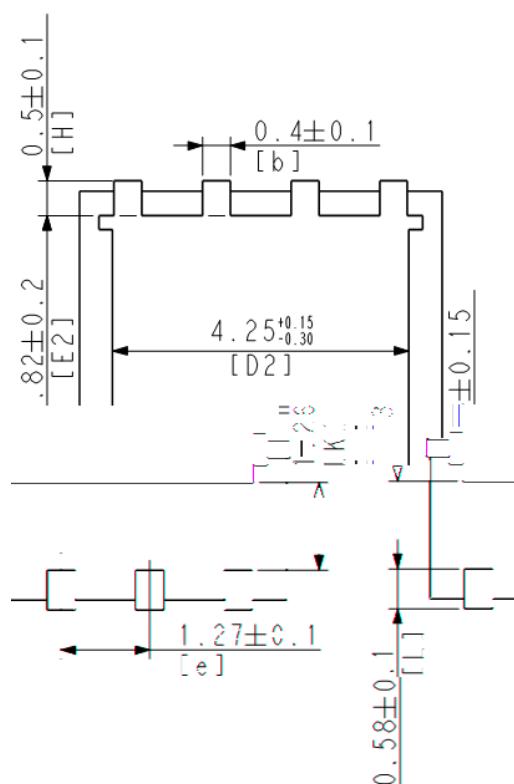
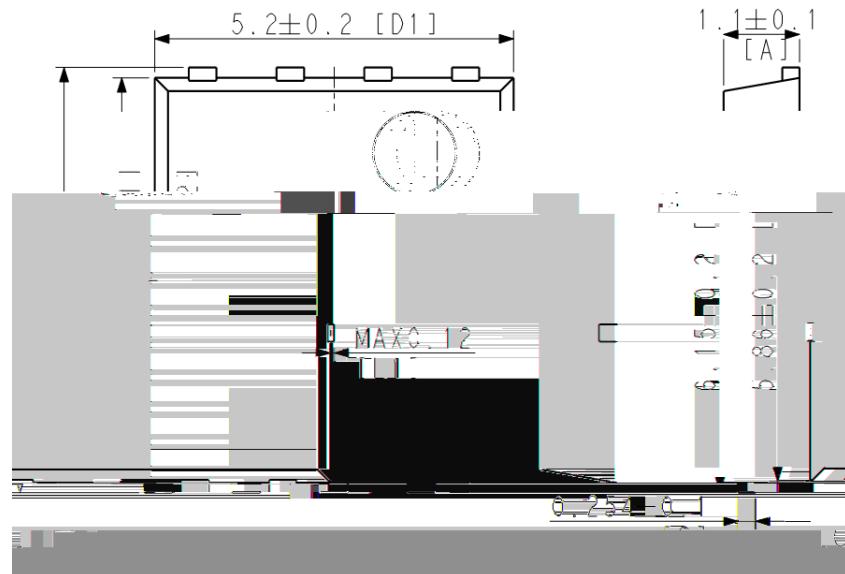
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Device Per Unit

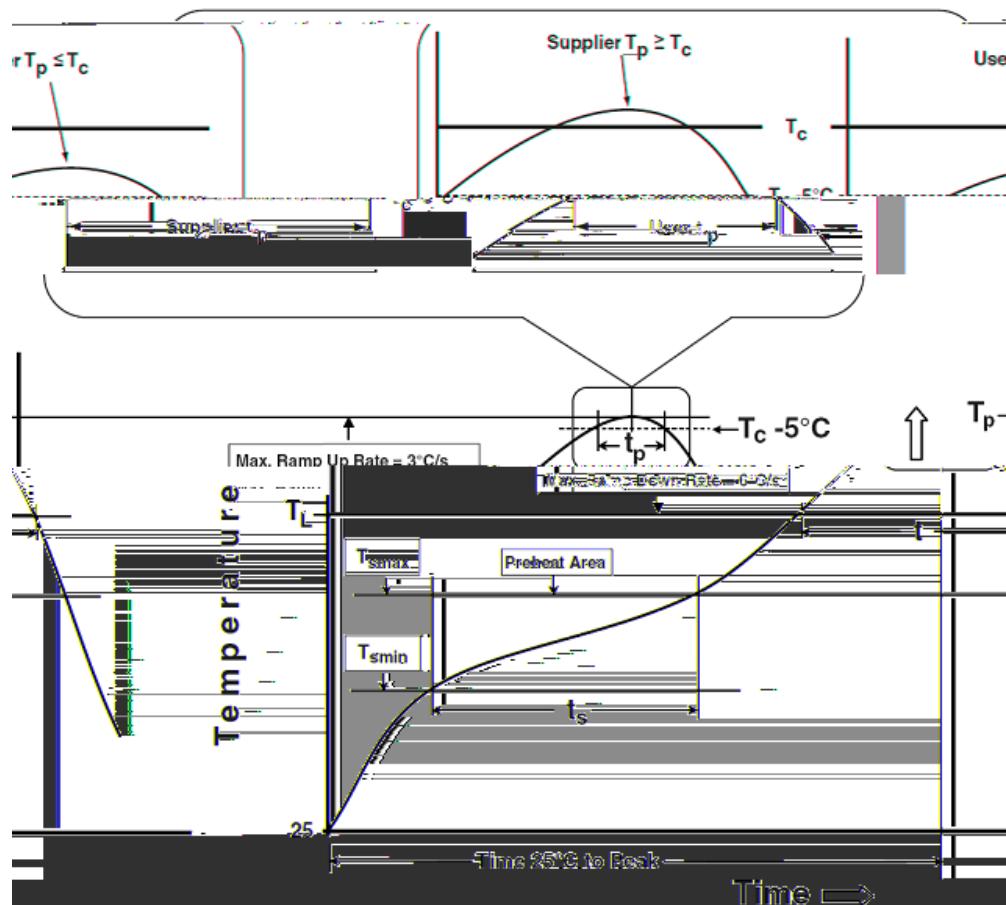
| Package Type | Unit | Quantity |
|--------------|------|----------|
| PPAK5*6-8L | Reel | 5000 |

Package Information

PPAK5*6-8L



Classification Profile



Classification Reflow Profiles

| Profile Feature | Sn-Pb Eutectic Assembly | Pb-Free Assembly |
|---|------------------------------------|------------------------------------|
| Preheat & Soak | | |
| Temperature min (T_{smin}) | 100 °C | 150 °C |
| Temperature max (T_{smax}) | 150 °C | 200 °C |
| Time (T_{smin} to T_{smax}) (t_s) | 60-120 seconds | 60-120 seconds |
| Average ramp-up rate (T_{smax} to T_p) | 3 °C/second max. | 3 °C/second max. |
| Liquidous temperature (T_L) | 183 °C | 217 °C |
| Time at liquidous (t_L) | 60-150 seconds | 60-150 seconds |
| Peak package body Temperature (T_p)* | See Classification Temp in table 1 | See Classification Temp in table 2 |
| Time (t_p)** within 5°C of the specified classification temperature (T_c) | 20** seconds | 30** seconds |
| Average ramp-down rate (T_p to T_{smax}) | 6 °C/second max. | 6 °C/second max. |
| Time 25°C to peak temperature | 6 minutes max. | 8 minutes max. |

*Tolerance for peak profile Temperature (T_p) is defined as a supplier minimum and a user maximum.
 ** Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.

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Table 1.SnPb Eutectic Process Classification Temperatures (Tc)

| Package Thickness | Volume mm <350 | Volume mm 350 |
|------------------------------|------------------------------|--------------------------|
| 2.5 mm | 235 °C | 220 °C |